Form PTO 1449		U.S. DEPARTMENT		ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TRAD	EMARK OFFICE	282602US8X PCT	10/577,928			
				APPLICANT				
LIST OF	REFEF	RENCES CITED BY API	PLICANT	Klaus HOLZAPFEL, et al.				
				FILING DATE		GROUP		
				May 1, 2006		2431		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
	AA	2005/0185926	08/25/2005	Camen Laura BASILE, et al.				
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO		
	AB	1365495A	08/21/2002	CHINA				×
	AC	2003-243993	08/29/2003	JAPAN (with English Abstract)				×
	AD	2003-187459	07/04/2003	JAPAN (with English Abstract)				X
	AE	2003-178461	06/27/2003	JAPAN (with English Abstract)				×
	AF	2003-6981	01/10/2003	JAPAN (with English Abstract)				Х
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ		Additional References sheet(s) attached					
Examiner					Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								
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